# **EMC TEST REPORT**

Product name:	Single Board Computer		
Model:	ODROID-C1		
Standards:	EN 55022:2010 EN 55024:2010 EN 61000-3-2:2006 + A1:2009 + A2:2009 EN 61000-3-3:2008		
Applicant:	Hardkernel Co., LTD.		
Test Report No.:	UCSCE-1412-204		

# UCS Co., Ltd.

#702, AnyangMegavalley, 268 Hagui-ro, Dongan-gu, Anyang-si, Gyeonggi-do, 431-767 Korea. Tel: +82-31-420-5680 / Fax: +82-31-420-5685 / Open Site: +82-31-355-2666 Online: http://www.ucs.co.kr





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EMC TEST REPORT						
Report Nur	nber	UCSCE-1412-204				
A	Company Name	Hardkernel Co., LTD.				
Applicant	Address	704 25, Simin-daero 248beon-	-gil, Dongan-gu, Anyang-si, Gy	eonggi-do, Korea		
	Product Name	Single Board Computer				
Product	Model No.	ODROID-C1				
Product	Manufacturer	Hardkernel Co., LTD.				
	Serial No.	-	Country of origin	Korea		
Other	Receipt Date	2014.12.10	Receipt Number	UCS-R-2014-886		
Other	Issued Date	2014.12.23	Tested Date	2014.12.19 ~ 2014.12.22		
St	EN 55022:2010         EN 55024:2010         EN 61000-3-2:2006 + A1:2009 + A2:2009         EN 61000-3-3:2008					
Te	Tested by K. S. Yoon (Sign)					
Арр	Approved by Y. M. Choi (Sign)					
UCS Co., Ltd. #702, AnyangMegavally, 268 Hagui-ro, Dongan-gu, Anyang-si, Gyeonggi-do, 431-767 Korea. Tel : +82-31-420-5680, Fax : +82-31-420-5685						
o This is certified that the above mentioned products have been tested for the sample provided by client. o No part of this document may not be duplicated or reproduced by any means without the express written permission of UCS Co., Ltd.						



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# **Revision History**

Issued Report No.	Issued Date	Revisions	Effect Section
UCSCE-1412-204	23-Dec-2014	Initial Issue	All



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# **1. Applicant Information**

Applicant Name	: Hardkernel Co., LTD.
Address	: 704 25, Simin-daero 248beon-gil, Dongan-gu, Anyang-si, Gyeonggi-do, Korea
Manufacturer	: Hardkernel Co., LTD.
Address	: 704 25, Simin-daero 248beon-gil, Dongan-gu, Anyang-si, Gyeonggi-do, Korea
Country of Origin	: Korea

# 2. EUT (Equipment under test) Information

Product Name	: Single Board Computer
Model	: ODROID-C1
Clock	: 12 MHz, 24 MHz, 25 MHz, 32.768 kHz
Operating system	: Xubuntu 14.04 (linux) or Android 4.4.X
Size	: PCB 85 x 56 mm
Weight	: 40 g
CPU	: Amlogic S805 Quad
Processor	: 1.5 GHz Quad Core Cortex-A5
Graphics processor	: Mali-450 MP2
System memory	: 1 024 MB
Network	: 10 / 100 / 1 000 Base-TX (1 Port)
USB	: Host 2.0 4 Port, Device 2.0 1 Port is not support on Linux (USB Storage Possible / ADB)
Storage	: microSD, microSDHC up to 32 GB, eMMC 8 GB / 16 GB / 32 GB / 64 GB (Accessory)
Video output	: HDMI 1.4a supports up to 1 920 x 1 080 resolution
Operating temperature	: 5 °C ~ 35 °C
Input Rating	: DC 5 V, < 10 W (2 A @ 5 V)

\* Product specification information described herein was obtained from product data sheet or user's manual.

# **3.** Laboratory Information

Laboratory Name	: UCS Co., Ltd.
Location	: 35-13, Hwalcho-gil, 109beon-gil, Hwaseong-si, Gyeonggi-do, 445-150 Korea.



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# 4. Test Configuration and Condition

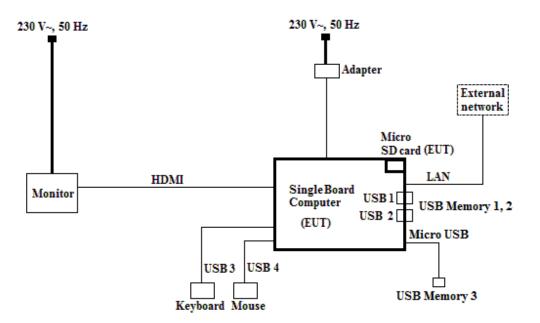
# 4.1 EUT operating condition

- After connecting a peripherals to the EUT, observed with video playback and ping test continuously during the test.

- Input power condition during the measurements was 230 V~, 50 Hz. (Adapter - Output: DC 5 V)

- At the request of the applicant tested using the Adapter but is not EUT.

# 4.2 EUT test configuration diagram



#### 4.3 Peripheral equipments list for test

Equipment Name	Model	Serial Number	Manufacturer
Single Board Computer	ODROID-C1	-	Hardkernel Co., LTD.
Micro SD card	-	-	San Disk
Adapter	SA-A136	-	WEIHAI SUNIN ELECTRONICS CO., LTD.
Mouse	N910U	K9P90900022	DONGGUAN KUNYING COMPUTER PRODUCTS CO., LTD.
Keyboard	KB212-B	-	Dell Inc.
Monitor	LT23B350	ZWL6HMCC806181L	SAMSUNG
USB Memory 1	Cruzer Edge	-	San Disk
USB Memory 2	-	-	-
USB Memory 3	-	-	-



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# 4.4 Cable connections

Start		End		Cable	
Name I/O Port		Name	I/O Port	Length	Spec.
	DC in	Adapter	DC out	1.6	Unshielded
	Card slot	Micro SD card	Card slot	-	-
Single Board Computer (EUT)	Video out	Monitor	Video in	0.8	Shielded
	USB 1, 2	USB memory 1, 2	USB	-	-
	USB 3	Keyboard	-	1.5	Unshielded
	USB 4	Mouse	-	1.6	Unshielded
	Micro USB	USB Memory 3	USB	0.2	Shielded
	LAN	External network	LAN	3.0	Unshielded

# 4.5 Information of the instruction for class A ITE

- Class A equipment shall be included the following warning in the instructions for use.

# WARNING

This is a class A product. In a domestic environment this product may cause radio interference in which case the user may be required to take adequate measures.

# 4.6 EUT modifications

None



# 5. Summary of Test Results

# 5.1 Summary of test results

Standard	Test Item	Results
	Conducted disturbance at the mains ports	Met Class A / Pass
EN 55022:2010	Conducted disturbance at the telecommunication ports	Met Class A / Pass
	Radiated disturbance	Met Class A / Pass
EN 61000-3-2:2006 + A1:2009 + A2:2009	Harmonics current emissions	Met / Pass
EN 61000-3-3:2008	Voltage changes, Voltage fluctuations and flicker	Met / Pass
	Electrostatic discharge	Met Criterion A and B / Pass
	Radiated RF electromagnetic field immunity	Met Criterion A / Pass
	Electrical fast transient/burst immunity	Met Criterion A / Pass
EN 55024:2010	Surge immunity	Met Criterion A / Pass
	Conducted disturbance induced by RF fields immunity	Met Criterion A / Pass
	Magnetic field immunity	N/A (See Note)
	Voltage dips and short interruptions	Met Criterion A and C / Pass

\* Note: The EUT does not contain devices susceptible to magnetic fields, so the test was not performed.

# 5.2 Performance of criteria

#### Performance criterion A

During and after the test the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a minimum performance level specified by the manufacturer when the EUT is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the EUT if used as intended.

#### Performance criterion B

After the test, the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the EUT is used as intended. The performance level may be replaced by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the EUT if used as intended.

#### Performance criterion C

During and after testing, a temporary loss of function is allowed, provided the function is selfrecoverable, or can be restored by the operation of the controls or cycling of the power to the EUT by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.



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# 6. Test Results

# 6.1 Conducted disturbance

Test Standard	EN 55022:2010, Class A			
Tested Date	2014.12.19			
Input Ratings	230 V~, 50 Hz			
Test result	Met Class A / Pass			

# 6.1.1 Limit

#### **Mains ports**

Frequency	Class A [dBµV]		Class B	[dBµV]
[MHz]	Quasi-Peak	Average	Quasi-Peak	Average
0.15 ~ 0.5	79	66	66 ~ 56*	56~46*
0.5 ~ 5	73	60	56	46
5~30	73	60	60	50

\* The limit decreases linearly with the logarithm of frequency.

#### **Telecommunication ports**

Frequency	Class A	[dBµV]	Class B [dBµV]		
[MHz]	Quasi-Peak	Average	Quasi-Peak	Average	
0.15 ~ 0.5	$97 \sim 87*$	$84 \sim 74*$	$84 \sim 74*$	74 ~ 64*	
0.5 ~ 30	87	74	74	64	

\* The limit decreases linearly with the logarithm of frequency.

# 6.1.2 Test set-up and procedure

The mains terminal disturbance voltage was measured with the equipment under test (EUT) in a shield room.

The EUT was connected to an artificial mains network (LISN) placed on the floor.

The EUT was placed on non-metallic table 0.8 m above the metallic, grounded floor.

The distance to other metallic surface was at least 0.8 m.

Amplitude measurements were performed with a quasi-peak detector and an average detector.

#### 6.1.3 Test equipment used

Equipment	Model	Serial No.	Vendor	Next Cal. Date	Use
Test Receiver	ESPI3	101171	ROHDE & SCHWARZ	2015.08.08	
Test Receiver	ESR7	101120	ROHDE & SCHWARZ	2015.01.03	
LISN	NSLK 8127	8127518	SCHWARZBECK	2015.08.28	
LISN	L3-32	1220X20311	PMM	2015.08.29	
ISN	ISN T800	30813	TESEQ	2015.02.11	
ISN	ISN T8-Cat6	29709	TESEQ	2015.02.11	



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# 6.1.4 Test set-up photos (Mains ports)



[Rear]





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# 6.1.5 Test set-up photos (Telecommunication ports)



[Front]

[Rear]





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# 6.1.6 Test data (Mains ports)

- Test Frequency rang : 150 kHz ~ 30 MHz : 9 kHz
- Bandwidth
- Temperature Humidity : (16.7 ± 0.4) °C : (22.55 ± 0.55) % R.H.

Engagonar	Fac	etor		Quasi-Peak			Average		
Frequency	LISN	Cable	Line	Limit	Reading	Results	Limit	Reading	Results
[MHz]	[dB]	[dB]		[dBµV]	[dBµV]	[dBµV]	[dBµV]	[dBµV]	[dBµV]
0.15	0.03	0.03	Ν	79.00	44.74	44.80	66.00	-	-
0.27	0.04	0.03	Н	79.00	48.77	48.84	66.00	-	-
0.34	0.04	0.04	Н	79.00	48.96	49.04	66.00	-	-
1.63	0.05	0.10	Н	73.00	52.60	52.75	60.00	-	-
6.10	0.11	0.29	Н	73.00	51.30	51.69	60.00	-	-
25.43	0.46	0.59	Ν	73.00	48.51	49.55	60.00	-	-

\* Remark: "H": Hot line, "N": Neutral line \* Average mode was not recorded, because Quasi-Peak values were under the Average limit.



# 6.1.7 Test data (Telecommunication ports)

- Test Frequency rang	: 150 kHz ~ 30 MHz
- Bandwidth	: 9 kHz

- Temperature	: (17.0 ± 0.5) °C
- Humidity	: (22.15 ± 0.75) % R.H.

#### [10 Mbps]

<b>F</b>	Factor		Quasi-peak			Average		
Frequency	ISN	Cable	Limit	Reading	Result	Limit	Reading	Result
[MHz]	[dB]	[dB]	[dBµV]	[dBµV]	[dBµV]	[dBµV]	[dBµV]	[dBµV]
0.17	10.13	0.03	95.96	27.21	37.37	82.96	-	-
0.29	9.95	0.04	91.52	34.39	44.38	78.52	-	-
0.33	9.92	0.04	90.45	34.81	44.77	77.45	-	-
1.58	9.64	0.10	87.00	54.31	64.05	74.00	-	-
3.35	9.58	0.16	87.00	54.35	64.09	74.00	-	-
6.05	9.55	0.28	87.00	49.04	58.87	74.00	-	-

\* Average mode was not recorded, because Quasi-Peak values were under the Average limit.

#### [100 Mbps]

Frequency	Factor		Quasi-peak			Average		
rrequency	ISN	Cable	Limit	Reading	Result	Limit	Reading	Result
[MHz]	[dB]	[dB]	[dBµV]	[dBµV]	[dBµV]	[dBµV]	[dBµV]	[dBµV]
0.17	10.13	0.03	95.96	29.50	39.66	82.96	-	-
0.20	10.03	0.03	94.61	29.72	39.78	81.61	-	-
0.29	9.95	0.04	91.52	35.47	45.46	78.52	-	-
0.62	9.74	0.06	87.00	44.99	54.79	74.00	-	-
1.63	9.64	0.10	87.00	54.77	64.50	74.00	-	-
3.38	9.58	0.17	87.00	53.53	63.27	74.00	-	-

\* Average mode was not recorded, because Quasi-Peak values were under the Average limit.



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[1 000 Mbps]

<b>F</b>	Fac	etor		Quasi-peak		Average		
Frequency	ISN	Cable	Limit	Reading	Result	Limit	Reading	Result
[MHz]	[dB]	[dB]	[dBµV]	[dBµV]	[dBµV]	[dBµV]	[dBµV]	[dBµV]
0.17	10.13	0.03	95.96	31.04	41.20	82.96	-	-
0.27	9.97	0.03	92.12	33.21	43.21	79.12	-	-
0.33	9.92	0.04	90.45	35.15	45.11	77.45	-	-
0.60	9.75	0.06	87.00	43.84	53.64	74.00	-	-
1.16	9.67	0.08	87.00	51.56	61.31	74.00	-	-
2.88	9.59	0.15	87.00	54.50	64.23	74.00	-	-

\* Average mode was not recorded, because Quasi-Peak values were under the Average limit.



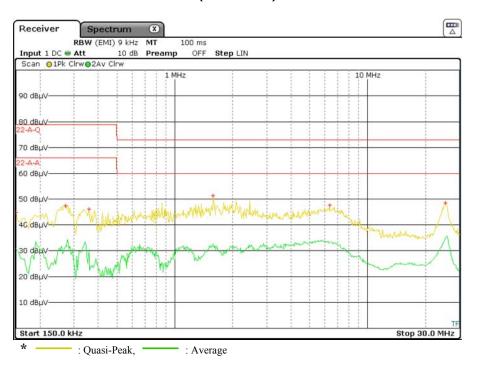
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# 6.1.8 Test graph (Mains ports)





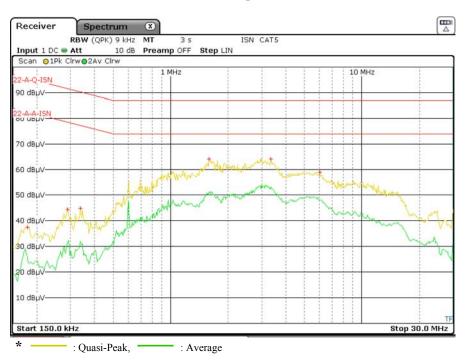
# [Neutral line]





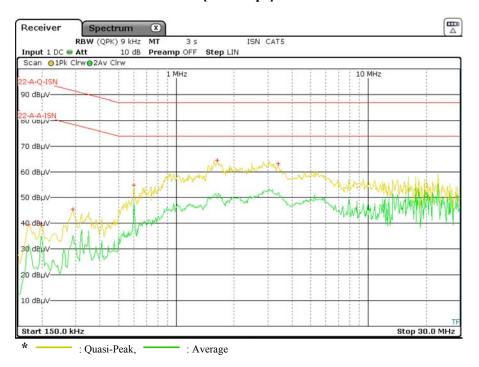
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# 6.1.9 Test graph (Telecommunication ports)

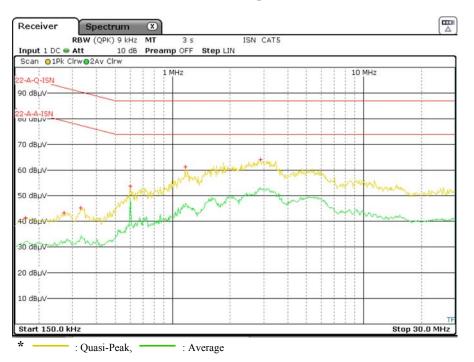




# [100 Mbps]







# [1 000 Mbps]



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# 6.2 Radiated disturbance (Below 1 GHz)

Test Standard	EN 55022:2010, Class A						
Tested Date	2014.12.19						
Input Ratings		230 V~, 50 Hz					
Temperature	$(11.7 \pm 0.3)$ °C	(11.7 $\pm$ 0.3) °C Humidity (18.45 $\pm$ 0.75) % R.H.					
Test result		Met Class A / Pass					

# 6.2.1 Limit

Frequency [MHz]	Class A [dBµV/m] @ 10 m	Class B [dBµV/m] @ 10 m		
30~230	40	30		
230 ~ 1 000	47	37		

# 6.2.2 Test set-up and procedure

A pretest was performed at 3 m distance in a semi-anechoic chamber for searching correct frequency.

The final test was done at a 10 m open area test site with a quasi-peak detector.

EUT was placed on a non-metallic table height of 0.8 m above the reference ground plane.

Cables were folded back and forth forming a bundle 0.3 m to 0.4 m long and were hanged at a 0.4 m height to the ground plane.

Cables connected to EUT were fixed to cause maximum emission. Test was made with the antenna positioned in both the horizontal and vertical planes of polarization.

The measurement antenna was varied in height above the conducting ground plane to obtain the maximum.

#### Next Cal. Date Equipment Model Serial No. Vendor Use ESPI3 101171 **ROHDE & SCHWARZ** 2015.08.08 Test Receiver Test Receiver ESR7 101120 **ROHDE & SCHWARZ** 2015.01.03 **VULB 9163** 691 **BI-LOG ANT** SCHWARZBECK 2016.02.28 **BI-LOG ANT** HLP-3003C 130526 TDK RF Solutions Inc. 2016.04.02 Antenna Master act-a400 20090812002 Audix Coporation \_ 2009814072 Turn Table act-t450 Audix Coporation -AMPLIFIER 310N SONOMA 2015.08.28 291723 Controller CT-0131 Audix Coporation act \_ 10 m OATS Semitec ---

# 6.2.3 Used test equipments



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# 6.2.4 Test set-up photos

# [Front]



[Rear]





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# 6.2.5 Test data

- Frequency Range	: 30 MHz ~ 1 000 MHz
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- Bandwidth

: 120 kHz

- Distance

:10 m

Freq. [MHz]	Reading [dBµV]	Antenna Polarity [H/V]	Height [m]	Antenna Factor [dB/m]	Cable Loss [dB]	Amp. Gain [dB]	Results [dBµV/m]	Limit [dBµV/m]	Margin [dB]
143.50	41.35	V	1.00	7.84	4.34	31.67	21.86	40.00	-18.14
236.43	46.13	V	1.00	12.06	5.83	31.61	32.41	47.00	-14.59
244.44	49.00	V	1.00	12.38	5.93	31.61	35.70	47.00	-11.30
518.25	27.10	Н	4.00	17.62	9.45	31.84	22.33	47.00	-24.67
743.15	32.30	Н	4.00	20.65	11.79	31.88	32.86	47.00	-14.14
961.34	27.30	Н	4.00	22.65	13.80	30.73	33.02	47.00	-13.98

\* Remark: "H": Horizontal, "V": Vertical

\* **Results**  $[dB\mu V/m]$  = Reading  $[dB\mu V]$  + Antenna Factor [dB/m] + Cable Loss [dB] - Amp. Gain [dB]\* **Margin** [dB] = Results  $[dB\mu V/m]$  - Limit  $[dB\mu V/m]$ 



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Test Standard		EN 55022:2010, Class A					
Tested Date		2014.12.19					
Input Ratings		230 V~, 50 Hz					
Temperature	$(12.05 \pm 1.15)$ °C	Humidity	(41.65 ± 1.05) % R.H.				
Test result		Met Class A / Pass					

# 6.3 Radiated disturbance (Above 1 GHz)

#### 6.3.1 Limit

Frequency	Class A [dBµV] @ 3 m		Class B [dBµV] @ 3 m		
[GHz]	Peak	Average	Peak	Average	
1~3	76	56	70	50	
3~6	80	60	74	54	

#### 6.3.2 Test set-up and procedure

The final test was done at a 3 m chamber with a peak and average detector.

EUT was placed on a non-metallic table height of 0.8 m above the reference ground plane.

Cables were folded back and forth forming a bundle 0.3 m to 0.4 m long and were hanged at a 0.4 m height to the ground plane.

Cables connected to EUT were fixed to cause maximum emission.

Test was made with the antenna positioned in both the horizontal and vertical planes of polarization.

The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength.

#### 6.3.3 Test equipment used

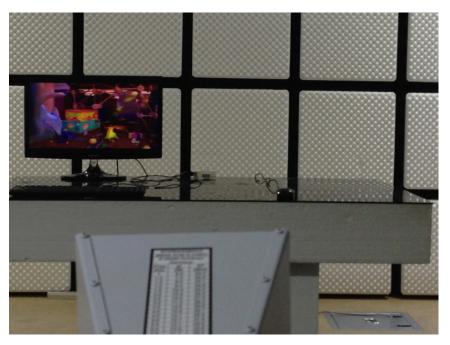
Equipment	Model	Serial No.	Vendor	Next Cal. Date	Use
Spectrum Analyzer	FSP13	100640	ROHDE & SCHWARZ	2015.01.03	
Test Receiver	ESR7	101120	ROHDE & SCHWARZ	2015.01.03	
HORN ANTENNA	BBHA 9120D	768 Schwarzbeck 2015.12.11			
Antenna Mast	-	-	Audix Coporation	-	
Turn Table	act-t300	-	Audix Coporation	-	
Microwave Preamplifier	8449B	3008A02014	Agilent	2015.03.10	
Controller	EM 1000	060558	Audix Corporation	-	



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# 6.3.4 Test set-up photos











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# 6.3.5 Test data

- Frequency Range	: 1 000 MHz ~ 6 000 MHz

- Bandwidth

: 1 MHz

- Distance

:3 m

[Peak]

Freq. [MHz]	Reading [dBµV]	Antenna Polarity [H/V]	Height [m]	Antenna Factor [dB/m]	Cable Loss [dB]	Amp. Gain [dB]	Results [dBµV/m]	Limit [dBµV/m]	Margin [dB]
1 215.00	58.60	V	1.00	24.46	9.48	36.71	55.83	76.00	-20.17
1 330.00	58.14	V	1.00	24.57	9.04	36.56	55.19	76.00	-20.81
3 300.00	50.92	V	1.00	28.69	10.55	35.19	54.97	80.00	-25.03
4 535.00	46.02	V	1.00	30.52	8.27	34.47	50.34	80.00	-29.66
5 185.00	45.73	V	1.00	31.79	8.38	34.32	51.58	80.00	-28.42
5 755.00	47.10	Н	1.00	32.40	8.77	34.33	53.94	80.00	-26.06

\* Remark: "H": Horizontal, "V": Vertical

\* Max. clock frequency: 1.5 GHz

\* Results  $[dB\mu V/m]$  = Reading  $[dB\mu V]$  + Antenna Factor [dB/m] + Cable Loss [dB] - Amp. Gain [dB]\* Margin [dB] = Results  $[dB\mu V/m]$  - Limit  $[dB\mu V/m]$ 

[Average]

Freq. [MHz]	Reading [dBµV]	Antenna Polarity [H/V]	Height [m]	Antenna Factor [dB/m]	Cable Loss [dB]	Amp. Gain [dB]	Results [dBµV/m]	Limit [dBµV/m]	Margin [dB]
1 215.00	42.06	V	1.00	24.46	9.48	36.71	39.29	56.00	-16.71
1 330.00	42.70	V	1.00	24.57	9.04	36.56	39.75	56.00	-16.25
3 300.00	34.70	V	1.00	28.69	10.55	35.19	38.75	60.00	-21.25
4 535.00	34.38	V	1.00	30.52	8.27	34.47	38.70	60.00	-21.30
5 185.00	34.73	V	1.00	31.79	8.38	34.32	40.58	60.00	-19.42
5 755.00	34.56	Н	1.00	32.40	8.77	34.33	41.40	60.00	-18.60

\* Remark: "H": Horizontal, "V": Vertical

\* Max. clock frequency: 1.5 GHz

\* **Results**  $[dB\mu V/m]$  = Reading  $[dB\mu V]$  + Antenna Factor [dB/m] + Cable Loss [dB] – Amp. Gain [dB]

\* Margin [dB] = Results  $[dB\mu V/m]$  – Limit  $[dB\mu V/m]$ 



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#### 6.4 Harmonics current emissions

Test Standard	EN 61	EN 61000-3-2:2006 + A1:2009 + A2:2009					
Tested Date	2014.12.19						
Input Ratings		230 V~, 50 Hz					
Temperature	$(21.6 \pm 0.4)$ °C	Humidity	$(39.05 \pm 0.55)$ % R.H.				
Test result		Met / Pass					

#### 6.4.1 Test setup and procedure

The equipment is supplied in series with shunt(s) Rms or current transformer(s) from a source having the same Nominal voltage and frequency as the rated supply voltage and frequency of the Measurements shall be made under Normal load, or conditions for adequate heat discharge, and underequipment.

Normal operating conditions. User's operation controls or automatic programmers shall be set to produce the maximum harmonic component, for each successive harmonic component in turn. For the purpose of harmonic current limitation, equipment is classified as follows:

Class A : Equipment not specified in one of the three other Classes shall be considered as Class A equipment.

- Balanced three-phase equipment;
- Household appliances, excluding equipment identified as class D;
- Tools, excluding portable tools;
- Dimmers for incandescent lamps;
- Audio equipment.

#### Class B:

- portable tools;
- arc welding equipment which is not professional equipment.

#### Class C:

- lighting equipment.

Class D: Equipment having a specified power according to 6.2.2 less than or equal to 600 W, of the following types:

- personal computers and personal computer monitors;
- television receivers.

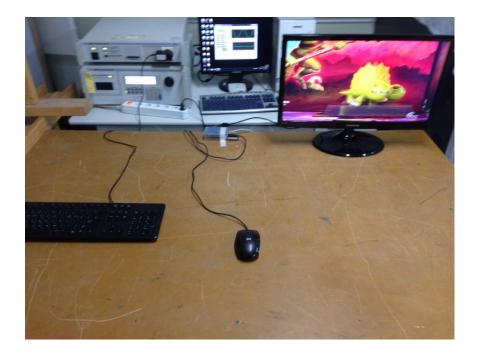
#### 6.4.2 Used test equipments

Equipment	Model	Serial No.	Vendor	Next Cal. Date	Use
Hamonics/Flicker	5001IX-208-150/300	S59160	C.I.	2015.10.13	



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# 6.4.3 Test set-up photos





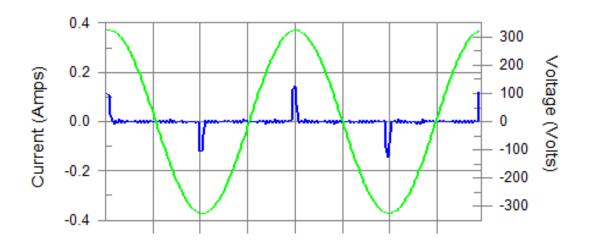
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# 6.4.4 Test data

# Harmonics - Class-A per Ed. 4.0 (2014)(Run time)

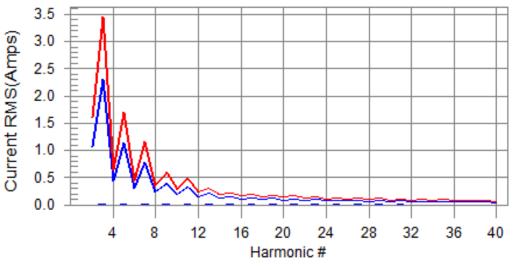
Test Result: Pass Source qualification: Normal

Current & voltage waveforms



Harmonics and Class A limit line

European Limits





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# Current Test Result Summary (Run time)

THC(A) Highest	Test Result: Pass Source qualification: Normal THC(A): 0.022 I-THD(%): 278.7 POHC(A): 0.000 POHC Limit(A): 0.251 Highest parameter values during test: V_RMS (Volts): 229.98 Frequency(Hz): 50.00							
	I_Peak (Amp	s): 0.165		I_RMS (Amps)				
	I_Fund (Amp			Crest Factor:	6.450			
	Power (Watts	s): 1.9		Power Factor:	0.347			
Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status	
2	0.000	1.080	N/A	0.000	1.620	N/A	Pass	
3	0.008	2.300	0.3	0.008	3.450	0.2	Pass	
4	0.000	0.430	N/A	0.000	0.645	N/A	Pass	
5	0.008	1.140	0.7	0.008	1.710	0.5	Pass	
6	0.000	0.300	N/A	0.000	0.450	N/A	Pass	
7	0.008	0.770	1.0	0.008	1.155	0.7	Pass	
8	0.000	0.230	N/A	0.000	0.345	N/A	Pass	
9	0.007	0.400	1.8	0.008	0.600	1.3	Pass	
10	0.000	0.184	N/A	0.000	0.276	N/A	Pass	
11	0.007	0.330	2.1	0.007	0.495	1.4	Pass	
12	0.000	0.153	N/A	0.000	0.230	N/A	Pass	
13	0.007	0.210	3.1	0.007	0.315	2.1	Pass	
14	0.000	0.131	N/A	0.000	0.197	N/A	Pass	
15	0.006	0.150	4.1	0.006	0.225	2.8	Pass	
16	0.000	0.115	N/A	0.000	0.173	N/A	Pass	
17	0.006	0.132	4.3	0.006	0.198	2.9	Pass	
18	0.000	0.102	N/A	0.000	0.153	N/A	Pass	
19	0.005	0.118	4.4	0.005	0.178	3.0	Pass	
20	0.000	0.092	N/A	0.000	0.138	N/A	Pass	
21	0.005	0.107	N/A	0.005	0.161	N/A	Pass	
22	0.000	0.084	N/A	0.000	0.125	N/A	Pass	
23	0.004	0.098	N/A	0.004	0.147	N/A	Pass	
24	0.000	0.077	N/A	0.000	0.115	N/A	Pass	
25	0.004	0.090	N/A	0.004	0.135	N/A	Pass	
26	0.000	0.071	N/A	0.000	0.107	N/A N/A	Pass	
27 28	0.003	0.083	N/A	0.003	0.125 0.099	N/A	Pass	
20	0.000 0.003	0.066 0.078	N/A N/A	0.000 0.003	0.099	N/A	Pass Pass	
30	0.000	0.061	N/A	0.000	0.092	N/A	Pass	
31	0.002	0.073	N/A	0.002	0.092	N/A	Pass	
32	0.002	0.075	N/A	0.002	0.086	N/A	Pass	
33	0.002	0.068	N/A	0.002	0.102	N/A	Pass	
34	0.002	0.054	N/A	0.002	0.081	N/A	Pass	
34	0.000	0.054	N/A	0.000	0.001	N/A	Pass	
36	0.000	0.064	N/A	0.002	0.090	N/A	Pass	
37	0.001	0.061	N/A	0.000	0.091	N/A	Pass	
38	0.000	0.048	N/A	0.000	0.073	N/A	Pass	
39	0.001	0.058	N/A	0.001	0.087	N/A	Pass	
40	0.000	0.046	N/A	0.000	0.069	N/A	Pass	
	0.000	01010		0.000	01000			

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# Voltage Source Verification Data (Run time)

Test Result: Pass Source qualification: Normal

Highes	t parameter values during to Voltage (Vrms): 229.98 I_Peak (Amps): 0.165 I_Fund (Amps): 0.008 Power (Watts): 1.9	Freq L_RM Cres	uency(Hz): 50.00 AS (Amps): 0.027 at Factor: 6.450 ver Factor: 0.347	
Harm#	Harmonics V-rms	Limit V-rms	% of Limit	Status
2 3	0.032 0.470	0.460 2.070	6.87 22.73	OK OK
4	0.470	0.460	3.13	ÖK
5	0.010	0.920	1.12	ÖK
6	0.015	0.460	3.23	ŏĸ
ž	0.050	0.690	7.25	ŏĸ
8	0.006	0.460	1.36	ŏĸ
9	0.118	0.460	25.67	ÖK
10	0.009	0.460	1.89	OK
11	0.070	0.230	30.45	oĸ
12	0.013	0.230	5.76	oĸ
13	0.031	0.230	13.43	OK
14	0.004	0.230	1.73	OK
15	0.015	0.230	6.49	OK
16	0.011	0.230	4.73	OK
17 18	0.006 0.015	0.230	2.75 6.62	OK OK
19	0.015	0.230	4.71	ŏĸ
20	0.013	0.230	5.60	ŏĸ
21	0.009	0.230	3.94	ŏĸ
22	0.005	0.230	2.09	ŏĸ
23	0.006	0.230	2.71	Ŏĸ
24	0.003	0.230	1.42	OK
25	0.006	0.230	2.62	OK
26	0.005	0.230	2.04	oĸ
27	0.003	0.230	1.22	OK
28	0.004	0.230	1.68	OK
29	0.008	0.230	3.29	OK
30 31	0.004	0.230 0.230	1.80 2.32	
32	0.005 0.002	0.230	0.98	ÖK
33	0.002	0.230	2.74	ŏĸ
34	0.003	0.230	1.18	ŏĸ
35	0.004	0.230	1.83	ŏĸ
36	0.003	0.230	1.29	ŏĸ
37	0.006	0.230	2.67	ŏĸ
38	0.003	0.230	1.13	ÖK
39	0.005	0.230	2.17	OK
40	0.009	0.230	3.87	OK

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# 6.5 Voltage changes, Voltage fluctuations and flicker

Test Standard		EN 61000-3-3:2008					
Tested Date		2014.12.19					
Input Ratings		230 V~, 50 Hz					
Temperature	$(21.7 \pm 0.5)$ °C	Humidity	$(38.15 \pm 0.75)$ % R.H.				
Test result		Met / Pass					

# 6.5.1 Test set-up and procedure

EUT was connected to the power analyzer system.

Measurement was performed to obtain the desired flicker parameters.

The measuring time depends on which parameters are to be measured.

Plt = 2 h

Pst = 10 min

Controls and automatic programs shall be set to produce the most unfavorable sequence of voltage changes,

using only those combinations of controls and programs are mentioned by the manufacturer in the instruction manual.

# 6.5.2 Used test equipments

Equipment	Model	Serial No.	Vendor	Next Cal. Date	Use
Hamonics/Flicker	5001IX-208-150/300	S59160	C.I.	2015.10.13	

# 6.5.3 Test set-up photos





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6.5.4 Test data

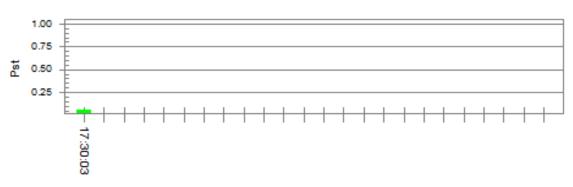
# Flicker Test Summary per EN/IEC61000-3-3 (Run time)

# Test Result: Pass

# Status: Test Completed

# Pst<sub>i</sub> and limit line

# European Limits



Plt and limit line



# Parameter values recorded during the test:Vrms at the end of test (Volt):229.95Highest dt (%):0.00T-max (mS):0Highest dc (%):0.00Highest dmax (%):0.00Highest Pst (10 min. period):0.064Highest Plt (2 hr. period):0.028

Test limit (%):	N/A	N/A
Test limit (mS):	500.0	Pass
Test limit (%):	3.30	Pass
Test limit (%):	4.00	Pass
Test limit:	1.000	Pass
Test limit:	0.650	Pass



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#### 6.6 Electrostatic discharge

Test Standard	EN 61000-4-2:2009, Criteria: B					
Test Level		HCP/VCP/Contact: $\pm 4 \text{ kV}$				
l est Level	Air: $\pm 2 \text{ kV}, \pm 4 \text{ kV}, \pm 8 \text{ kV}$					
Discharge Impedance		330 Ω / 150 pF				
Test Time	at le	at least 25 times for each adapting point				
Tested Date		2014.12.19				
Input Ratings		230 V~, 50 Hz				
Temperature	$(21.9 \pm 0.7)$ °C	(21.9 $\pm$ 0.7) °C Humidity (39.9 $\pm$ 0.7) % R.H.				
Atmospheric pressure	102.7 kPa					
Test Result		Met criterion A and B / Pass				

#### 6.6.1 Test set-up and procedure

A ground reference plane was located on the floor, and connected to earth via a low Impedance connection.

The return cable of the ESD generator was connected to the reference plane.

In case of floor standing equipment, EUT was placed on the reference plane on 0.1 m of insulating Support.

In case of table top equipment, EUT was placed on a wooden table 0.8 m above the reference grounded floor.

A horizontal coupling plane (HCP) was placed on the table, and Connected to the reference plane via a 470 kohm resistor located in each end (0.5 mm insulating support between EUT and HCP).

In both cases a vertical coupling plane (VCP) of 0.5 m x 0.5 m was located 0.1 m from the EUT's sides.

The VCP was connected to the reference plane in the same matter as the HCP.

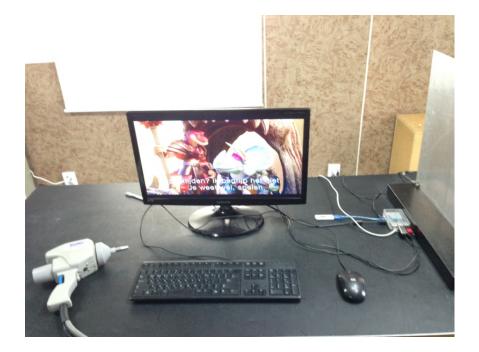
#### 6.6.2 Used test equipments

Equipment	Model	Serial No.	Vendor	Next Cal. Date	Use
ESD Simulator	ESS-2000	4010C63927	NoiseKen	2015.08.28	
HAEFELY TEST AG	ONYX 16	177897	HAEFELY TECHNOLOGY	2015.04.04	
НСР	-	-	-	-	
VCP	-	-	-	-	



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# 6.6.3 Test set-up photos





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B (See note 2)

# 6.6.4 Test data

Location	Applied Level (±)		Criteria	Results
VCP	4 kV	4 kV		$\Lambda$ (See note 1)
НСР	4 kV	4 kV		A (See note 1)
			<b>a :</b>	
Location (EUT)	Applied Level (±)	Method	Criteria	Results
(1) USB, LAN Part	4 kV	Contact	В	$\Lambda$ (See moto 1)
(2) HDMI, Micro USB, Cover Part	2 kV, 4 kV, 8 kV Air		В	A (See note 1)

\* Note 1: There was no deviation from normal operation condition.

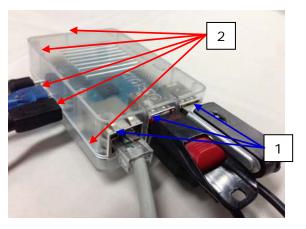
(3) Power port Part

\* Note 2: The flicker was observed on the monitor during the test, but return to normal operating condition after the test.

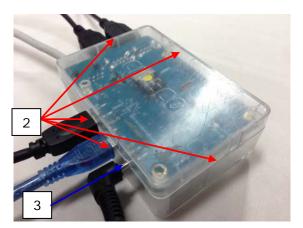
Contact

 $4 \, \mathrm{kV}$ 





В





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# 6.7 Radiated RF electromagnetic field immunity

Test Standard	EN 61000-4-3:2006 + A1:2008 + A2:2010, Criteria: A			
Tested Frequency		$80 \ MHz \sim 1.0 \ GHz$		
Test Level/Modulation		3 V/m (AM 80 %, 1 kHz)		
Distance		3 m		
Dwell Time	3 s			
Step Size	log 1 % step			
Tested Date	2014.12.19			
Input Ratings		230 V~, 50 Hz		
Temperature	(24.15 $\pm$ 0.55) °C <b>Humidity</b> (39.9 $\pm$ 1.1) % R.H.			
Atmospheric pressure	102.5 kPa			
Test Result		Met criterion A / Pass		

# 6.7.1 Test set-up and procedure

The test was performed at 3 m full anechoic chamber.

For floor standing equipment, the EUT was standing on the floor.

For tabletop equipment, the EUT was located on a wooden table 0.8 m above the floor.

The EUT was tested all sides, horizontal and vertical polarization.

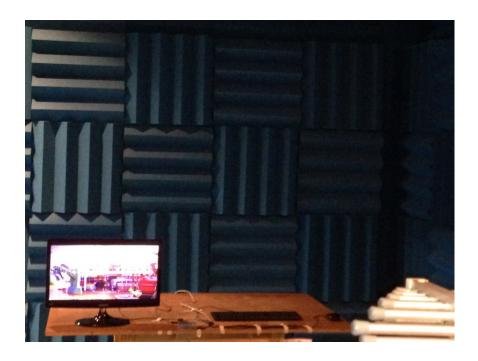
#### 6.7.2 Used test equipments

Equipment	Model	Serial No.	Vendor	Next Cal. Date	Use
SIGNAL GENERATOR	SMC100A	101441	ROHDE & SCHWARZ	2015.08.28	
EMP Series Power Meter	E4419B	MY45104421	Agilent	2015.08.28	
E-SERIES AVG	E0204A	MX41400022	Acilant	2015 09 29	_
POWER SENSOR	E9304A	MY41499023	Agilent	2015.08.28	
RF AMPLIFIER	25A250AM1	0331227	AMPLIFRER RESEARCH	-	
RF AMPLIFIER	30S1G3M1	0331152	AMPLIFRER RESEARCH	-	
RF AMPLIFIER	150W1000M1	0331746	AMPLIFRER RESEARCH	-	-
Horn Antenna	AT4002A	0330909	AMPLIFRER RESEARCH	-	
LOG-PER ANTENNA	VULP 9118 E	855	SCHWARZBECK	-	



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# 6.7.3 Test set-up photos



# 6.7.4 Test data

Location (EUT)	Antenna Polarization	Results	Results
Front Side	Horizontal	А	А
Front Side	Vertical	А	А
Deer Cile	Horizontal	А	А
Rear Side	Vertical	А	А
L . Q. Q. 1.	Horizontal	А	А
Left Side	Vertical	А	А
D: 1 - 0: 1	Horizontal	А	А
Right Side	Vertical	А	А

\* There was no deviation from normal operation condition.



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Test Standard	EN 61000-4-4:2012, Criteria: B			
Coupling		Coupling Decoupling Network		
Test Level	AC Mai	ins: $\pm 1$ kV Peak, Signal: $\pm 0.5$	kV Peak	
Repetition Freq.		5 kHz, Tr / Th = 5 / 50 ns		
Coupling Time	60 s			
Tested Date	2014.12.22			
Input Ratings		230 V~, 50 Hz		
Temperature	$(20.55 \pm 0.65)$ °C	Humidity	(46.5 ± 1.1) % R.H.	
Atmospheric pressure	102.2 kPa			
Test Result		Met criterion A / Pass		

# 6.8 Electric fast transient/burst immunity

#### 6.8.1 Test set-up and procedure

A ground reference plane was located on the floor.

EFT generator was connected to reference ground plane via low impedance connection.

For floor standing equipment, EUT was placed on a 0.1 m wooden table.

For tabletop equipment, EUT was placed on a 0.1 m above the ground reference plane.

Test generator and coupling/decoupling network was placed on, and bounded to, the ground reference plane.

When using the coupling clamp, the minimum distance between the coupling plates and all other conductive surfaces, except the ground reference plane beneath the coupling clamp, Shall be 0.5 m.

#### 6.8.2 Used test equipments

Equipment	Model	Serial No.	Vendor	Next Cal. Date	Use
EMC IMMUNITY TEST	EMCPRO PLUS	0906221	ThermoFisher Scientific	2015.08.28	
Capacitive Clamp	CCL	0904227	ThermoFisher Scientific	2015.08.29	



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# 6.8.3 Test set-up photos



#### 6.8.4 Test data

EFT Coupling Point	Level (±)	Criteria	Results
L	1 kV	В	А
N	1 kV	В	А
L - N	1 kV	В	А
LAN	0.5 kV	В	А

\* There was no deviation from normal operation condition.



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# 6.9 Surge immunity

Test Standard	EN 61000-4-5:2006, Criteria: B			
Coupling		Coupling Decoupling Netwo	rk	
Test Level	AC	Mains (Line to Line): $\pm$ (0.5,	1) kV	
Surge Pulse Shape	$Tr/Th = 1.2/50 \ \mu s \ (8/20 \ \mu s)$			
Number of surge/time	1 time / 1 min, total 5 times			
Tested Date	2014.12.22			
Input Ratings		230 V~, 50 Hz		
Temperature	(19.7 $\pm$ 0.9) °C <b>Humidity</b> (43.45 $\pm$ 1.15) % R.H.			
Atmospheric pressure	102.2 kPa			
Test Result		Met criterion A / Pass		

# 6.9.1 Test set-up and procedure

A ground reference plane was located on the floor. SURGE generator was connected to reference ground plane via low impedance connection. For floor standing equipment, EUT was placed on a 0.1 m wooden table.

For table top equipment, EUT was placed on a wooden table (0.1 m) above the reference plane.

# 6.9.2 Used test equipments

Equipment	Model	Serial No.	Vendor	Next Cal. Date	Use
EMC IMMUNITY TEST	EMCPRO PLUS	0906221	ThermoFisher Scientific	2015.08.28	
I/O Lin Coupler/Decoupler	CM-I/OCD	0906226	ThermoFisher Scientific	-	
Telecom	CM-TELCD	0905226	ThermoFisher Scientific	-	
coupler/Decoupler					



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# 6.9.3 Test set-up photos



#### 6.9.4 Test data

Coupling Point	Level (±)	Criteria	Results	
L to N	0.5 kV, 1 kV	В	А	

\* There was no deviation from normal operation condition.\* The EUT does not have the signal ports that may connect directly to outdoor cables.



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# 6.10 Conducted disturbance induced by RF fields immunity

Test Result	Met criterion A / Pass				
Atmospheric pressure	102.4 kPa				
Temperature	(20.3 ± 0.7) °C <b>Humidity</b> (42.3 ± 0.6) % R.H.				
Input Ratings	230 V~, 50 Hz				
Tested Date	2014.12.22				
Step Size	log 1 % step				
Dwell Time	3 s				
Coupling Method	AC Mains: M2, Signal: EM Clamp				
Test Level/Modulation	3 V (AM 80 %, 1 kHz)				
Tested Frequency	150 kHz ~ 80 MHz				
Test Standard	EN 61000-4-6:2009, Criteria: A				

# 6.10.1 Test set-up and procedure

A ground reference plane was located on the floor

The test was performed on a ground reference plane on a 0.1 m wooden table.

This test were performed using CDN for mains, clamp for signal and injection probe.

The frequency range was swept from 150 kHz to 100 MHz. This frequency range was modulated with 1 kHz sine wave at 80 %.

The signal generators provided the modulated frequency at a 1 % step size

The power and all network cable, I/O cables longer than 3 m length were tested

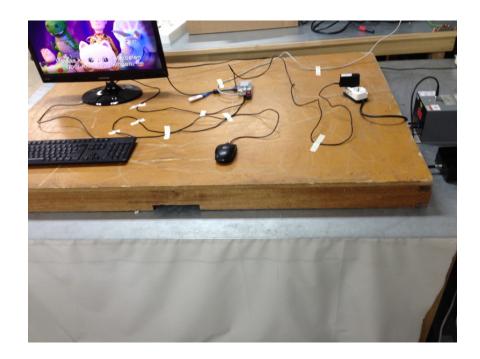
#### 6.10.2 Used test equipments

Equipment	Model	Serial No.	Vendor	Next Cal. Date	Use
CDN M2	FCC-801-M2-16A	091165	091165 FCC		
CDN M3	FCC-801-M3-16A	091994 FCC		2015.08.28	
EM INJECTION CLAMP	F-203I-23mm	091199	FCC	2015.01.02	
Continuous Wave Simulator	CWS 500N1	P1247105423	EM Test	2015.02.20	
Coaxial Fixed Attenuator ATT6/75		P1306112966	EM Test	2015.02.20	



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# 6.10.3 Test set-up photos



# 6.10.4 Test data

Coupling Point	Coupling Method	Criteria	Results	
AC Mains	CDN (M2)	А	А	
LAN	EM Clamp	А	А	

\* There was no deviation from normal operation condition.



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# 6.11 Voltage dips and short interruptions

Test Standard	EN 61000-4-11:2004, Criterion : B or C				
Number of reduction	3 T				
Duration	10 s				
Phase	Zero crossing (0°, 180°)				
Tested Date	2014.12.22				
Input Ratings	100-240 V~, 50 Hz				
Temperature	(21.0 $\pm$ 0.4) °C <b>Humidity</b> (43.45 $\pm$ 1.05) % R.H.				
Atmospheric pressure	$(102.35 \pm 0.05)$ kPa				
Test result	Met criterion A and C / Pass				

# 6.11.1 Test set-up and procedure

The dips/interruption test is only applicable to AC mains.

The dips/interruptions were applied at zero crossing

# 6.11.2 Used test equipments

Equipment	Model	Serial No.	Vendor	Next Cal. Date	Use
EMC IMMUNITY		000(221	ThermoFisher	2015 09 29	_
TEST	EMCPRO PLUS	0906221	Scientific	2015.08.28	



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# 6.11.3 Test set-up photos



# 6.11.4 Test data

Test	Test Level (% U <sub>T</sub> )	Periods	Criteria	Results
V-loss disc	> 95 %	0.5	В	A (Sec. 1)
Voltage dips	30 %	25	С	A (See note 1)
Voltage interruptions	> 95 %	250	С	C (See note 2)

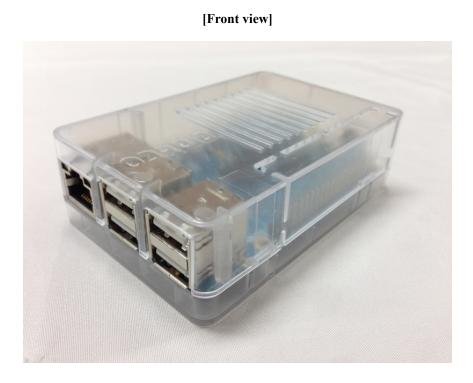
\* Note 1: There was no deviation from normal operation condition.
\* Note 2: The power of EUT was turned off during the test, but returned to normal operating condition after the test.
\* Test result of both 100 V~ and 240 V~ are same.



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# 7. EUT Photos

# 7.1 External view



# [Rear view]





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# 7.2 Internal view





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# 7.3 Internal Board



